# **MOSFET** - Single N-Channel

## 80 V, 5.9 mΩ, 84 A

## NTTFS5D9N08H

#### **Features**

- Max  $R_{DS(on)} = 5.9 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 23 \text{ A}$
- Max  $R_{DS(on)} = 9 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 12 \text{ A}$
- High Performance Technology for Extremely Low R<sub>DS(on)</sub>
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- DC-DC Buck Converters
- Point of Load
- High Efficiency Load Switch and Low Side Switching
- Oring FET

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	80	٧	
Gate-to-Source Voltage		V <sub>GS</sub>	±20	٧	
Continuous Drain Current $R_{\theta JC}$ (Note 1)	Steady	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	84	Α
Power Dissipation $R_{\theta JC}$ (Note 1)	State		P <sub>D</sub>	100	W
$\begin{array}{c} \text{Continuous Drain} \\ \text{Current R}_{\theta JA} \\ \text{(Notes 1, 2)} \end{array}$	Steady State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	13	Α
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)	Oldic		P <sub>D</sub>	2.7	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	535	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Diode)		Is	83	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>AV</sub> = 40 A, L = 0.1 mH) (Note 3)		E <sub>AS</sub>	80	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	54.8	

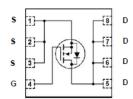
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz. Cu pad.
- 3. E<sub>AS</sub> of 80 mJ is based on started  $T_J$  = 25°C,  $I_{AS}$  = 40 A,  $V_{DD}$  = 80 V,  $V_{GS}$  = 10 V. 100% test at  $I_{AS}$  = 40 A.



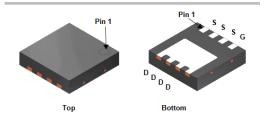
## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	5.9 mΩ @ 10 V	84 A
80 V	9 mΩ @ 6 V	04 A



#### **N-CHANNEL MOSFET**



WDFN8 3.3X3.3, 0.65P CASE 483AW

## **MARKING DIAGRAM**



S5D9 = Specific Device Code
A = Assembly Plant Code
Y = Numeric Year Code
WW = Work Week Code
ZZ = Assembly Lot Code

## **ORDERING INFORMATION**

Device	Package	Shipping†
NTTFS5D9N08HTWG	PQFN8 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D =$	250 μΑ	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA, ref to 25°C			42.91		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	: 120 μA	2.0		4.0	٧
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 120 μA, ref	to 25°C		-6.81		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 23 A		4.6	5.9	mΩ
		V <sub>GS</sub> = 6 V, I <sub>D</sub>	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 12 A		6.6	9.0	
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub>	= 23 A		135		S
Gate-Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			1		Ω
CHARGES & CAPACITANCES						ı	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			2040		pF
Output Capacitance	Coss				303		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				12		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 6 V, V <sub>DS</sub> = 64 V, I <sub>D</sub> = 11.5 A			20		nC
Total Gate Charge	Q <sub>G(TOT)</sub> (10V)				31		
Gate-to-Source Charge	Q <sub>GS</sub>				8.4		
Gate-to-Drain Charge	$Q_{GD}$				6.8		
Plateau Voltage	$V_{GP}$				4.4		V
SWITCHING CHARACTERISTICS (Note	4)				•	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 6 V, $V_{DS}$ = 64 V, $I_{D}$ = 11.5 A, $R_{G}$ = 2.5 $\Omega$			17.2		ns
Rise Time	t <sub>r</sub>				8.7		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				21.6		
Fall Time	t <sub>f</sub>				5.8		
DRAIN-SOURCE DIODE CHARACTERIS	STICS				•	•	•
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 23 A	T <sub>J</sub> = 25°C		0.8	1.2	V
			T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A}/\mu\text{s,}$ $I_S = 11.5 \text{ A}$			39		ns
Reverse Recovery Charge	Q <sub>RR</sub>				28		nC
Charge Time	ta	$V_{GS} = 0 \text{ V, dI}_S/dt = 100 \text{ A}/\mu\text{s,} \\ I_S = 11.5 \text{ A}$			21		ns
Discharge Time	t <sub>b</sub>				16		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Switching characteristics are independent of operating junction temperatures

5. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

## **TYPICAL CHARACTERISTICS**

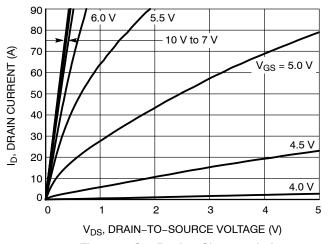


Figure 1. On-Region Characteristics

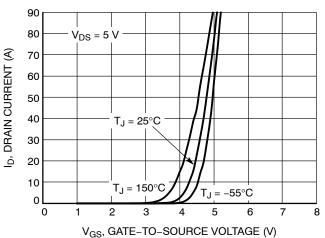


Figure 2. Transfer Characteristics

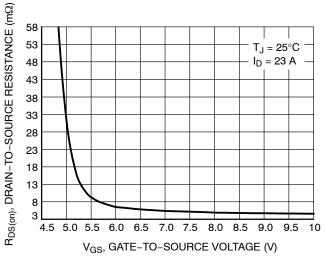


Figure 3. On-Resistance vs. Gate-to-Source Voltage

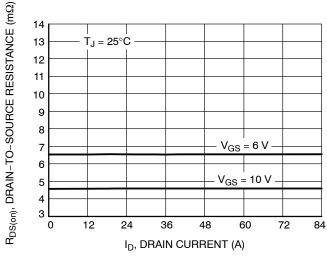


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

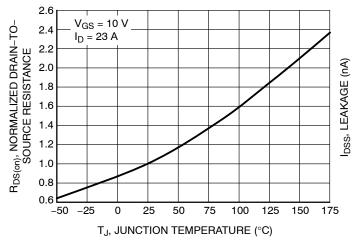


Figure 5. On–Resistance Variation with Temperature

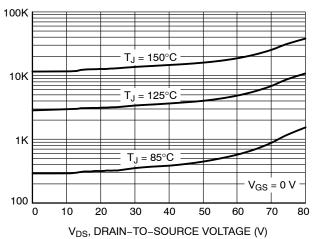


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL CHARACTERISTICS**

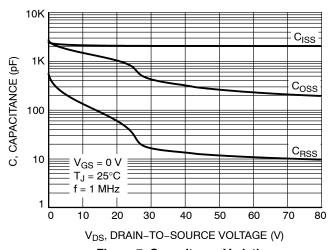


Figure 7. Capacitance Variation

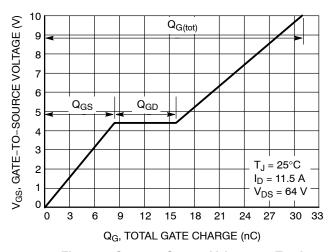


Figure 8. Gate-to-Source Voltage vs. Total Charge

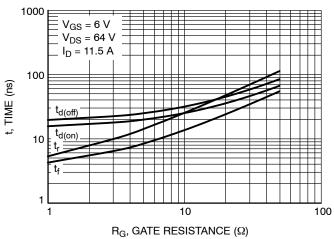


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

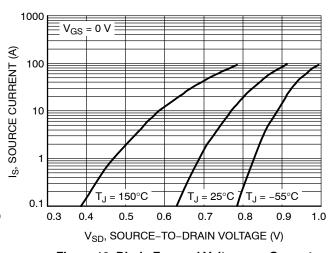


Figure 10. Diode Forward Voltage vs. Current

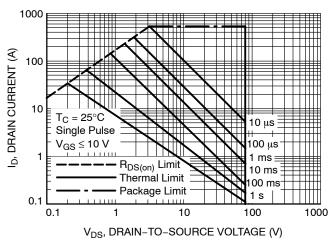


Figure 11. Maximum Rated Forward Biased Safe Operating Area

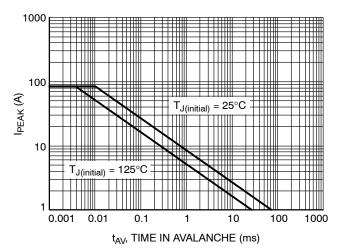


Figure 12. Maximum Drain Current vs. Time in Avalanche

## **TYPICAL CHARACTERISTICS**

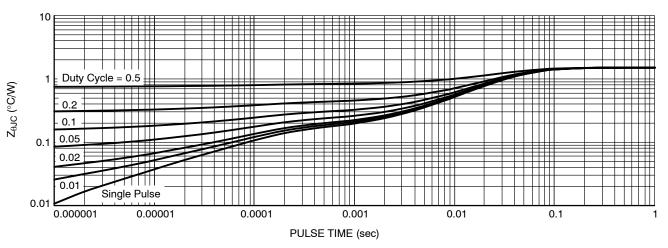


Figure 13. Transient Thermal Impedance



Α

5

TOP VIEW

В



TERMINAL #1

INDEX AREA

(D/2 X E/2)

☐ aaa C

## WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

**DATE 22 MAR 2024** 

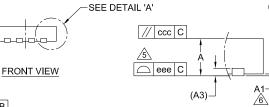
#### NOTES:

C

SEATING

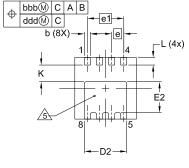
**PLANE** 

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



aaa C

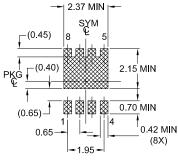
2X



**BOTTOM VIEW** 

LAND PATTERN RECOMMENDATION

DETAIL A



\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

MILLIMETERS				
MIN	NOM	MAX		
0.70	0.75	0.80		
		0.05		
	0.20 REF	•		
0.27 0.32 0.37				
3.30 BSC				
2.17	2.27	2.37		
3.30 BSC				
1.56 1.66		1.76		
0.65 BSC				
1.95 BSC				
0.90				
0.30 0.40		0.50		
0.10				
0.10				
0.10				
0.05				
0.05				
	0.27 0.27 2.17 1.56	MIN NOM 0.70 0.75 0.20 REF 0.27 0.32 3.30 BSC 2.17 2.27 3.30 BSC 1.56 1.66 0.65 BSC 0.90 0.30 0.40 0.10 0.10 0.10 0.05		

MILLIMETERS

## GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1	

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